Engineering polar distortions in multiferroic $\text{Sr}_{1-x}\text{Ba}_x\text{MnO}_{3-\delta}$ thin films

Panagiotis Koutsogiannis; Pedro A. Algarabel; José A. Pardo; César Magén

APL Mater. 12, 011113 (2024)
https://doi.org/10.1063/5.0174793
Engineering polar distortions in multiferroic Sr$_{1-x}$Ba$_x$MnO$_{3-\delta}$ thin films

Cite as: APL Mater. 12, 011113 (2024); doi: 10.1063/5.0174793
Submitted: 2 September 2023 • Accepted: 17 December 2023 • Published Online: 18 January 2024

Panagiotis Koutsogiannis,$^{1,2}$ Pedro A. Algarabel,$^{1,2}$ José A. Pardo,$^{1,3,4}$ and César Magén$^{1,2,5,*}$

AFFILIATIONS

$^1$ Instituto de Nanociencia y Materiales de Aragón (INMA), CSIC-Universidad de Zaragoza, 50009 Zaragoza, Spain
$^2$ Departamento de Física de la Materia Condensada, Universidad de Zaragoza, 50018 Zaragoza, Spain
$^3$ Laboratorio de Microscopías Avanzadas (LMA), Universidad de Zaragoza, 50018 Zaragoza, Spain
$^4$ Departamento de Ciencia y Tecnología de Materiales y Fluidos, Universidad de Zaragoza, 50018 Zaragoza, Spain
$^5$ Author to whom correspondence should be addressed: cmagend@unizar.es

ABSTRACT

The physical properties of perovskite oxide thin films are governed by the subtle interplay between chemical composition and crystal symmetry variations, which can be altered by epitaxial growth. In the case of perovskite-type multiferroic thin films, precise control of stoichiometry and epitaxial strain allows for gaining control over the ferroic properties through selective crystal distortions. Here, we demonstrate the chemical tailoring of the polar atomic displacements by tuning the stoichiometry of multiferroic Sr$_{1-x}$Ba$_x$MnO$_{3-\delta}$ ($0 \leq \delta \leq 0.5$) epitaxial thin films. A combination of x-ray diffraction and aberration-corrected scanning transmission electron microscopy enables unraveling the local polarization orientation at the nanoscale as a function of the film’s composition and induced crystalline structure. We demonstrate experimentally that the orientation of polarization is intimately linked to the Ba doping and O stoichiometry of the films and, with the biaxial strain induced by the substrate, it can be tuned either in-plane or out-of-plane with respect to the substrate by the appropriate choice of the post-growth annealing temperature and O$_2$ atmosphere. This chemistry-mediated engineering of the polarization orientation of oxide thin films opens new venues for the design of functional multiferroic architectures and the exploration of novel physics and applications of ferroelectric textures with exotic topological properties.

© 2024 Author(s). All article content, except where otherwise noted, is licensed under a Creative Commons Attribution (CC BY) license (http://creativecommons.org/licenses/by/4.0/). https://doi.org/10.1063/5.0174793

I. INTRODUCTION

Multiferroic magnetoelectric materials present exciting fundamental physics and appealing functional properties. The coexistence of magnetic and polar orders, and the emergence of coupling between them, have compelled the scientific community to explore new pathways toward their applications in diverse technologies, such as low-power data storage and memories$^{3,5}$, energy storage$^{6–8}$ and photovoltaics$^{9}$, or neural networks.$^{10}$ Of particular interest are multiferroic oxides comprising the ABO$_3$ perovskite structure, which offer a plethora of physical phenomena driven by small variations of stoichiometry and crystal symmetry.$^{11–13}$ Thin films present additional degrees of freedom, which can be explored in the quest for new multiferroic materials, such as low dimensionality or substrate-induced strain.$^{14–16}$ In many perovskite thin films, such as SrTiO$_3$, EuTiO$_3$, or KTaO$_3$, epitaxial strain can induce ferroelectricity by coupling with soft phonon modes, which stabilizes lower-symmetry, non-centrosymmetric phases.$^{11}$ Similarly, magnetoelectric effects can emerge under epitaxial strain or chemical pressure, due to the strong coupling between lattice, charge, spin, and orbital degrees of freedom, which exists when the B cation has partially filled 3$d^0$ orbitals.$^{17,18}$ Particularly, antiferromagnetic materials can show prominent magnetoelectric coupling under biaxial strain by suppressing the antiferromagnetic exchange interaction as a consequence of ionic displacements.$^{19}$

An exciting family of multiferroics is AMnO$_3$ (A = Ca, Sr, Ba) perovskite. These are antiferromagnets$^{19}$ or weak ferromagnets$^{19}$, presenting ferroelectricity$^{20}$ driven by the off-centering of the magnetic Mn$^{4+}$. The first-principles calculations of Bhattacharjee et al.$^{21}$ predicted the emergence of a multiferroic state in CaMnO$_3$ upon mechanical or chemical strain engineering. Günter et al.$^{20}$ provided experimental evidence of incipient ferroelectricity in epitaxially
strained CaMnO$_3$ films grown on LaAlO$_3$ substrates. Lee and Rabe$^{22}$ also predicted the multiferroic nature of cubic SrMnO$_3$ under strain, while soon after, Becher $et$ $al.$$^{23}$ unraveled its polar nature using temperature-dependent second harmonic generation. Recently, the ferroelectric nature of SrMnO$_3$ thin films has been experimentally demonstrated at low temperatures (10 K),$^{24}$ while room-temperature ferroelectricity has been accessible via selective oxygen annealing.$^{25}$ A remarkable advance was the room-temperature stabilization of the ferroelectric perovskite phase in Sr$_{1-x}$Ba$_x$MnO$_3$ single crystals (x $\geq$ 0.45) evidenced by ferroelectric hysteresis at 2 K.$^{26}$ Bulk Sr$_{1-x}$Ba$_x$MnO$_3$ in thermodynamic equilibrium shows the hexagonal 4H structure, while a cubic perovskite polymorph appears above 1400 °C only for low Ba contents (x $\leq$ 0.15).$^{27}$ Different strategies have been followed to prepare the metastable perovskite phase at room temperature up to x = 0.5, having lattice parameters between 3.806 Å (x = 0) and ~3.900 Å (x = 0.5).$^{28,29}$ Langenberg $et$ $al.$$^{29}$ showed that Sr$_{1-x}$Ba$_x$MnO$_3$-$\delta$ (SBMO, 0 $\leq$ x $\leq$ 0.5) epitaxial thin films with pseudocubic (tetragonally distorted cubic) structure can be grown on several perovskite substrates under the appropriate experimental conditions and below a critical film thickness. Those films were coherently strained and had a lattice mismatch with the substrate ranging between 0% and 4%, which paved the way for epitaxial strain engineering of this family. For a particular substrate, the strain of the films can be tuned from tensile to compressive and change its magnitude by modifying the Ba content and the concentration of oxygen vacancies.$^{29}$

The polar nature of SrMnO$_3$ thin films has been widely studied by scanning transmission electron microscopy and second harmonic generation, while electrical and magnetic properties have been investigated by spectroscopy and scanning probe microscopy techniques among others.$^{29,30,32}$ In SrMnO$_3$ films under tensile epitaxial strain, the polar displacements occur along the in-plane (0111) pseudocubic crystal directions, and the formation of polar domains has been evidenced.$^{33}$ Furthermore, polar gradients can emerge via the modulation of strain and oxygen content.$^{34}$ However, the impact of Ba and O content on the type of polar displacements as well as the structural and electrical properties of Sr$_{1-x}$Ba$_x$MnO$_3$-$\delta$ films has drawn little attention so far.

In the present work, we deposited epitaxial Sr$_{1-x}$Ba$_x$MnO$_3$-$\delta$ thin films using targets with different Ba contents (0 $\leq$ x $\leq$ 0.5) and various post-annealing conditions (O$_2$ pressure, substrate temperature) to regulate the concentration of oxygen vacancies ($\delta$) of the films. Scanning transmission electron microscopy was utilized to comprehensively examine the impact of Ba content and O stoichiometry on the polar atomic displacements in biaxial strained films on single-crystalline substrates. Our results evidence a chemistry-mediated control of the polar states observed in these films. The magnitude and orientation of the polar displacements can be tuned by the Ba content and the O stoichiometry from in-plane to out-of-plane with respect to the substrate. Finally, we show that polar displacements are highly dependent on the cooperative effects between the growth parameters that can be refined desirably, smoothing the path toward new tailored multiferroic architectures.

II. RESULTS AND DISCUSSION

SBMO films synthesized under various conditions were investigated. The effects of different Ba and O content on the crystalline structure of the films were studied both separately and jointly. The starting point was the growth of Sr$_{1-x}$Ba$_x$MnO$_3$-$\delta$ (0 $\leq$ x $\leq$ 0.5) films with the best crystal quality and the highest oxygen content. Then, the impact of Ba doping on the crystal structure and the atomic displacements was investigated in these samples. Next, we varied the annealing conditions (O$_2$ pressure and substrate temperature) to deliberately induce oxygen vacancies in the films and evaluate their effect on the crystal structure down to the atomic scale. For the sake of simplicity, the role of each growth or post-growth parameter will be discussed separately, to conclude with a discussion on the combined effects of both variables.

A. Effect of Ba content

Sr$_{1-x}$Ba$_x$MnO$_3$-$\delta$ (x = 0, 0.4, and 0.5) thin films were grown on LSAT substrates using different $in$ $situ$ annealing conditions depending on the Ba content. X-ray diffraction (XRD) was used to refine the optimized growth conditions (see Fig. S3 of the supplementary material) and to determine the samples with the best crystal quality and the maximum oxygen content, which were selected for further characterization. The optimal annealing parameters, listed in Table I, were influenced by the Ba doping and strain, since both favor the formation of oxygen vacancies as a countermeasure against the expanded cell volume.$^{35}$ Film thickness values were t = 18 nm for x = 0, t = 11 nm for x = 0.4, and t = 7 nm for x = 0.5, selected just below the critical thickness estimated by Langenberg $et$ $al.$$^{29}$ Symmetric θ/2θ scans were performed to analyze the effect of the chemical substitution of Sr with the larger Ba cation on the out-of-plane lattice parameter. Figure 1(a) shows the θ/2θ scans in the vicinity of the 002 LSAT peak in the three films with different compositions (x = 0, 0.4, and 0.5), prepared under the annealing

| Table I. Annealing conditions and main structural parameters of optimized SBMO films as a function of the Ba content (x): annealing temperature (T$_{\text{ann}}$, °C), annealing O$_2$ pressure (P$_{\text{ann}}$, Torr), thickness (t), out-of-plane lattice parameter (c), in-plane lattice parameter (a), in-plane strain ($\varepsilon_{\text{xx}}$) calculated as 100 × (c$_{\text{bulk}}$ - c$_{\text{film}}$)/c$_{\text{bulk}}$, ratio between out-of-plane and in-plane lattice parameter (c/a), and cell volume (V). |
|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|
| x              | T$_{\text{ann}}$ (°C) | P$_{\text{ann}}$ (Torr) | t (nm) | c (Å) | a (Å) | $\varepsilon_{\text{xx}}$ | c/a | V (Å$^3$) |
| 0              | 800             | 500             | 18    | 3.76(1) | -1.2% | 3.868          | +1.6% | 0.972(3) | 56.2(2) |
| 0.4            | 350             | 590             | 11    | 3.84(2) | -0.4% | 3.868          | +0.3% | 0.993(6) | 57.5(3) |
| 0.5            | 650             | 350             | 7     | 3.93(4) | +0.8% | 3.868          | +0.3% | 1.02(1) | 58.8(6) |

© Author(s) 2024
out-of-plane lattice parameter increases drastically, the c/a ratio were collected to analyze the degree of strain induced by the subsequence of the reduced film thickness. Reciprocal space maps (RSM) = their high crystal quality, while their absence in x tensile strain, in the case of the highest Ba content (x = 0.4, proving their high crystal quality, while their absence in x = 0.5 is a consequence of the reduced film thickness. Reciprocal space maps (RSM) were collected to analyze the degree of strain induced by the substrate. As shown in Fig. 1(b) for the parent compound SrMnO₃, the coincidence of the in-plane component of the reciprocal space vector of the 013 asymmetric reflection of both film and substrate evidence that the epitaxial film is fully strained. Similar RSM experiments in x = 0.4 and 0.5 films yielded inconclusive results due to the poor visibility of the film’s peak in thinner films. Coherent growth was confirmed in these films by an alternative, local structural analysis performed by aberration-corrected scanning transmission electron microscopy (STEM). Geometrical phase analysis (GPA, see the Experimental section) of the cross-sectional high-angle annular dark field (HAADF) images of the three films was performed to determine the relationship between the lattice parameters of the film and the substrate, as depicted in Figs. 1(c)–1(e). The in-plane lattice parameter remains constant (within a statistical error of 0.05%) across the interface between the film and the substrate. Thus, the out-of-plane lattice parameter (c), the c/a ratio, and the cell volume listed in Table 1 could be determined from the XRD and STEM analysis shown in Fig. 1 for the x = 0, 0.4, and 0.5 films. This summary allows us to conclude that, together with the out-of-plane lattice parameter, the cell volume also increases, as should be expected, by doping with the larger Ba cation. This trend might affect the kind of polar displacements occurring in these films.

While for x = 0.4 the SBMO film still grows under slight tensile strain, in the case of the highest Ba content (x = 0.5), the out-of-plane lattice parameter increases drastically, the c/a ratio becomes larger than unity, and thus compressive strain emerges. This extensive increase occurs even though Ba content rises only 10%, signifying the impact of the low-oxygen annealing conditions (compared to x = 0 and 0.4 films) on the cell volume. According to theoretical predictions, the phase diagrams of epitaxial ferroelectric thin films are bound to mechanical boundary conditions, absent in free crystals, which may trigger phases that are hindered in the bulk. Moreover, first-principles studies of epitaxial strain in perovskites indicate that the change from tensile to compressive strain can induce a rotation of the polarization from the in-plane to the out-of-plane direction. Hence, it is plausible that, in our SBMO films for x = 0.5, polar displacements relocate (relative to x = 0.4) toward a non-centrosymmetric out-of-plane configuration. Figure 2 shows atomic-resolution annular bright field (ABF) STEM images of cross-sectional specimens of the SrMnO₃ and Sr₀.₃Ba₀.₇MnO₃₋₅ films, grown in the optimal conditions (Table 1), observed along the [110] zone axis. The images were taken at the interfaces between the LSAT substrates and the films. In ABF configuration, both the cation and the oxygen sublattices can be visualized simultaneously. Polar displacements previously observed in epitaxial SrMnO₃ films along the (110) directions are confirmed in this case. Oxygen shifts are predominantly in-plane, with an average displacement of ~8 pm with respect to the centro-symmetric positions. However, Mn shifts of ~7 pm in-plane are limited to the interfacial region, whereas out-of-plane displacements are negligible within the margins of error. On the other hand, in the case of Sr₀.₃Ba₀.₇MnO₃₋₅, oxygen out-of-plane displacements are dominant with values of ~15 pm, whereas minor in-plane displacements of ~5 pm were detected. Atomic displacements observed in the LSAT substrate, which is a cubic centrosymmetric crystal, are associated with other experimental factors such as interfacial strain and a slight mistilt with respect to the film’s orientation, and disappear when the substrate is specifically oriented in zone axis a few nanometers from the interface (see the supplementary material, Figs. S8 and S9). Overall, a
FIG. 2. ABF-STEM images of cross-sectional specimens of (a) SrMnO$_3$/LSAT (001) and (b) Sr$_{0.5}$Ba$_{0.5}$MnO$_3$−δ/LSAT (001) viewed along the ⟨110⟩ direction. The insets show magnified images of the specimens, and the arrows represent the average magnitude and orientation of the spontaneous polarization of each atomic row of the film. Out-of-plane polar displacements are dominant in the Sr$_{0.5}$Ba$_{0.5}$MnO$_3$−δ film, while mostly in-plane polar shifts emerge in SrMnO$_3$. The O and Mn out-of-plane (Δz) and in-plane (Δx) shifts shown in both figures are visualized in the corresponding displacement plots. The average in-plane ($P_x$), out-of-plane ($P_z$) and overall ($P_s$) spontaneous polarization of the crystal cells across the thickness of the films are shown in the polarization plot.

spontaneous polarization with a maximum value of 30 μC/cm$^2$ is present in the two films, which is in the range of polarization values predicted in SrMnO$_3$ for moderate tensile strain similar to the 1.7% nominal value of films grown on LSAT. It is worth noting that in the case of the SrMnO$_3$ film, the spontaneous polarization is predominantly in-plane, while in Sr$_{0.5}$Ba$_{0.5}$MnO$_3$−δ films out-of-plane polarization dominates, as illustrated with the arrows overlay on the ABF-STEM images of Fig. 2. Indeed, this result is the first experimental evidence of out-of-plane polar displacements induced in compressively strained films in this family of compounds.

The very different critical thicknesses for strain relaxation of the three compositions and the inhomogeneous polar states found in the ultrathin (10 nm) films of SrMnO$_3$ led us to study the effect of Ba content in films with optimized, subcritical thickness values, different for each composition. However, size effects related to reduced thickness can have a significant impact on the structural and electrical properties of ferroelectric films through strain variation and screening of polarization at the interface, which can drastically affect the domain wall structure, polarization, switching, and imprint phenomena. In order to distinguish the possible impact of thickness from that of stoichiometry, we have analyzed the influence of oxygen content for the same Ba doping in specimens with constant thickness.

B. Oxygen stoichiometry

The formation of oxygen vacancies affects the physical properties of SrMnO$_3$ thin films, such as conductivity and magnetic
order. In \( \text{Sr}_{1-x}\text{Ba}_x\text{MnO}_3 \) (\( x \geq 0.4 \)), oxygen vacancies emerge even at high annealing oxygen pressures as shown in other experimental works, mainly due to the increased chemical pressure. Lattice distortions induced by epitaxial strain are also bound to influence the oxygen stoichiometry in SMO films. Indeed, it could also be engineered by modifying the temperature and oxygen pressure during growth and post-growth annealing, as has been shown in the bulk. Thus, we analyzed the influence of oxygen content on the polar states of oxygen-deficient \( \text{Sr}_{0.6}\text{Ba}_{0.4}\text{MnO}_3 \) films, which show a value of tensile strain near the threshold (\( c/a = 1 \)) toward compressive strain (see Table II), by varying the temperature and oxygen pressure of the annealing. We avoided using \( \text{Sr}_{0.5}\text{Ba}_{0.5}\text{MnO}_3 \) as an agent to study the effect of oxygen vacancies since it was highly metastable and susceptible to oxygen content changes (see Fig. S3 in the supplementary material).

A detailed study was performed on two \( \text{Sr}_{0.6}\text{Ba}_{0.4}\text{MnO}_3 \) films synthesized with the same growth conditions but annealed at 550°C, 400 Torr \( \text{O}_2 \), and 650°C, 300 Torr \( \text{O}_2 \) for 1 h, respectively (parameters that are different from the ones of the optimized film discussed in Sec. II A). The thickness was constrained to 12 nm, which is again below the critical value reported by Langenberg et al. It is noteworthy that the impact of the different annealing conditions (temperature and pressure) is visible in the XRD symmetric \( \theta/2\theta \) scans shown in Fig. 3(a). The 002 main reflection of the film annealed at 550°C and 400 Torr \( \text{O}_2 \) appears at a higher 2θ value than the LSAT 002 reflection, very similar to the optimized film (see Fig. 1), while that of the film annealed at 650°C, 300 Torr \( \text{O}_2 \) appears at a 2θ angle lower than the substrate’s one. The resulting out-of-plane lattice parameters of the films were 3.85 ± 0.01 Å and 3.89 ± 0.01 Å for annealing pressures of 400 and 300 Torr, respectively. These values indicate that decreasing the oxygen pressure and increasing the temperature during annealing causes the enlargement of the out-of-plane lattice parameter, and thus the cell volume. More importantly, the consequence of changing the annealing conditions is the transition from a tensile strained film (\( c/a < 1 \)) in a highly oxidizing atmosphere to a compressively strained structure (\( c/a > 1 \)) in more reducing conditions.

Electron energy loss spectroscopy (EELS) analysis has been carried out to quantify the combined influence of different annealing temperature and pressure on the number of oxygen vacancies (δ)

### Table II

<table>
<thead>
<tr>
<th>( x )</th>
<th>( T_{\text{ann}} ) (°C)</th>
<th>( P_{\text{ann}} ) (Torr)</th>
<th>( t ) (nm)</th>
<th>( c ) (Å)</th>
<th>( \varepsilon_{zz} )</th>
<th>( a ) (Å)</th>
<th>( \varepsilon_{xx} )</th>
<th>( c/a )</th>
<th>( V ) (Å³)</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.4</td>
<td>550</td>
<td>400</td>
<td>12</td>
<td>3.83(1)</td>
<td>-0.6%</td>
<td>3.868</td>
<td>+0.3%</td>
<td>0.993(3)</td>
<td>57.3(3)</td>
</tr>
<tr>
<td>0.4</td>
<td>650</td>
<td>300</td>
<td>12</td>
<td>3.89(1)</td>
<td>+1.0%</td>
<td>3.868</td>
<td>+0.3%</td>
<td>1.010(4)</td>
<td>58.3(3)</td>
</tr>
</tbody>
</table>

**FIG. 3.** (a) Symmetric \( \theta/2\theta \) scans of epitaxial \( \text{Sr}_{0.6}\text{Ba}_{0.4}\text{MnO}_3 \) films grown on LSAT with low oxygen content (annealed at 650°C, 300 Torr \( \text{O}_2 \)) and high oxygen content (annealed at 550°C, 400 Torr \( \text{O}_2 \)). The position of the main peak of the film (dashed lines) moves toward smaller 2θ angles (out-of-plane lattice parameter \( c = 3.894 ± 0.008 \) Å) in the case of low oxygen content due to the enlargement of the out-of-plane lattice parameter as a result of the higher concentration of oxygen vacancies. The out-of-plane lattice parameter of the high oxygen content film is \( c = 3.832 ± 0.007 \) Å. (b) EELS spectra of the O K edge acquired in the vicinity of 530 eV from the \( \text{Sr}_{0.6}\text{Ba}_{0.4}\text{MnO}_3 \) films shown in (a). Low oxygen content (\( \delta = 0.25 \)) spectrum is shown in red and high oxygen content (\( \delta = 0.15 \)) in purple. 1D Gaussian fits of the pre-peak (−529 eV) and the main peak (−536 eV) of the O–K edge fine structure are plotted. The dashed lines indicate the center of the peaks which were used to estimate the Mn valence of the films.
by estimating the Mn valence. The experimental O–K edge of the two aforementioned Sr$_{0.6}$Ba$_{0.4}$MnO$_{3-\delta}$ films is depicted in Fig. 3(b), together with the Gaussian fits used to calculate the Mn valence (as described in the Methods section). The estimated values of the Mn valence are $+3.69 \pm 0.05$ ($\delta \approx 0.15 \pm 0.01$) and $+3.51 \pm 0.05$ ($\delta \approx 0.25 \pm 0.01$) for the films with high and low oxygen pressure annealing, respectively. Therefore, the Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.75}$ film annealed at 650 °C, 300 Torr O$_2$ accommodates more oxygen vacancies than the Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.85}$ film annealed at 550 °C and 400 Torr O$_2$, which is in agreement with the evolution of their out-of-plane lattice parameter deduced from Fig. 3(a). The lower average Mn valence, driven by the formation of oxygen vacancies, implies a larger ionic radius.

**FIG. 4.** ABF-STEM images of cross-sectional specimen of the (a) Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.85}$ and (b) Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.75}$ grown on LSAT (001) and annealed at (a) 400 Torr, 550 °C and (b) 300 Torr, 650 °C for 1 h, viewed along the (110) direction. The insets show a magnified image of the specimen, and the arrows indicate the average magnitude and orientation of the spontaneous polarization of each atomic row of the film. The O and Mn out-of-plane ($\Delta z$) and in-plane ($\Delta x$) displacements shown in both figures are visualized in the corresponding displacement plots. Out-of-plane polarization is dominant in the Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.75}$ film, while in-plane polarization dictates in the case of the more oxidized Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.85}$ film. The estimated average in-plane (Px), out-of-plane (Pz) and overall (Ps) spontaneous polarization of the crystal cells across the thickness of the films are shown in the polarization plot.
which increases the out-of-plane lattice parameter and the cell volume. Our results follow the description of Dabrowski et al., where the valence of the Mn$^{++}$ ion, its radius, and therefore the cell volume can be adjusted as a function of the oxygen vacancies.

Oxygen content also drastically changes the polar order of Sr$_{0.6}$Ba$_{0.4}$MnO$_{3-\delta}$ thin films. A quantitative analysis of the polar displacements in ABF-STEM images of the same two Sr$_{0.6}$Ba$_{0.4}$MnO$_{3-\delta}$ films is shown in Fig. 4. Specifically, the Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.85}$ sample encounters in-plane polar displacements of O of $\sim$15 pm, qualitatively similar to those observed in the nearly stoichiometric parent compound SrMnO$_3$ [Fig. 2(a)]. In contrast, out-of-plane shifts of the equatorial oxygen positions up to $\sim$28 pm are detected in the Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.75}$ sample. Thus, a change of polar displacements from in-plane to out-of-plane can be induced purely by modifying the oxygen stoichiometry at a constant thickness.

Quantitative analysis of the ABF image of the Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.85}$ film [see Fig. 4(a)] shows a spontaneous polarization of about 30 $\mu$C/cm$^2$ arising mostly from the contribution of oxygen in-plane shifts, similar to tensile-strained in-plane polar SBSO films shown elsewhere. A radically different behavior is observed in the Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.75}$ film displayed in Fig. 4(b), where spontaneous polarization up to 95 $\mu$C/cm$^2$ owing to large out-of-plane and in-plane shifts of the oxygen atoms has been computed. This value is remarkably higher than that observed in the rest of the films studied here and is in good agreement with those estimated by Guzmán et al. using a similar methodology in oxygen-deficient SrMnO$_3$ films. In that case, out-of-plane polar rotations were observed associated with a concomitant gradient of oxygen vacancies and strain across the film thickness. This might be an indication that highly oxygen-deficient SBSO films also favor larger polarization values with respect to stoichiometric ones. It also suggests that small variations of the atomic displacements observed in the ABF images of the films could be associated with small local variations in the oxygen stoichiometry.

Hence, these observations prove experimentally that, among the different demonstrations of how oxygen stoichiometry can influence the crystal structure and functional properties of oxide thin films, the polar axis of SBSO multiferroic thin films can also be switched from in-plane to out-of-plane orientation by tuning the concentration of oxygen vacancies.

C. Synergistic effects

A theoretical study from Marthinsen et al. states that the expansion of the cell volume promotes polar distortions as a consequence of the decrease in the Coulomb repulsion between the displaced Mn cation and the O anions. However, in the case of tensile strain, polar distortions compete with the formation of oxygen vacancies, which can suppress polarization. Therefore, by gaining control over the oxygen vacancies and Ba content, we can stimulate polar distortions in SBSO and selectively induce either in-plane or out-of-plane polar displacements.

Intriguingly, the emergence of out-of-plane polar displacements in the compressively strained Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.75}$ film grown on LSAT is an example of a synergistic effect between Ba content and oxygen stoichiometry. High Ba content ($x = 0.4$) and low oxygen content ($\delta = 0.25$) promote the emergence of compressive strain and trigger the displacement of oxygen atomic columns out-of-plane, as shown in Fig. 4.

Finally, Ba content and oxygen stoichiometry are not mutually independent parameters. Substituting Sr with Ba at the A sites causes an increase in the average ionic radius at the A position, inducing a rise in the cell volume that in turn favors the formation of oxygen vacancies. From the energy point of view, Ba doping decreases the oxygen vacancy formation energy in epitaxial SBSO films, and inevitably more oxygen vacancies may emerge, as explained elsewhere. This interplay between Ba and O stoichiometry is evidenced in Fig. 5, which shows O-K EELS spectra collected from the optimal films shown in Fig. 1 with different Ba content ($x = 0, 0.4,$ and 0.5). The experimental value of Mn valence in the parent compound SrMnO$_3$ was $+4.02 \pm 0.03$, which indicates a fully stoichiometric crystal. On the other hand, in high Ba content samples, the highest Mn valence we reported was $+3.82 \pm 0.05$ for $x = 0.4$ and $+3.75 \pm 0.05$ for $x = 0.5$, respectively.

III. CONCLUSIONS

In this work, we evidence a chemistry-mediated route to engineer the polar distortions of strained single-crystalline Sr$_{1-x}$Ba$_x$MnO$_3$ thin films. Once the in-plane lattice parameter of the films is fixed by the biaxial epitaxial strain of the LSAT (001) substrate, the magnitude and orientation of the polar displacements observed are tailored by modifying the Ba doping and oxygen stoichiometry through post-growth annealing. The combined effect of Ba doping, oxygen vacancies and epitaxy directs the polar displacements out-of-plane in a compressively strained Sr$_{0.5}$Ba$_{0.5}$MnO$_{3-\delta}$ films, while the stoichiometric parent compound SrMnO$_3$ shows in-plane displacements driven by tensile strain as a function of the Ba composition and growth parameters. Last but not least, we observe that the polar displacements can be switched from in-plane to out-of-plane by modulating the oxygen stoichiometry alone for a given Ba doping, as large out-of-plane polarization emerges in highly oxygen deficient Sr$_{0.6}$Ba$_{0.4}$MnO$_{2.75}$ thin films grown on LSAT. We attribute this effect to the rise of Mn$^{3+}$ ions under reducing conditions.
conditions, which contribute to the increase in the cell volume and, thus, the out-of-plane lattice parameter in these fully coherent, epitaxial films. In summary, our findings show that the cooperative action of tailored stoichiometry and epitaxial strain is critical for the emergence and control of polar states in this family of compounds, and the impact of growth conditions on the crystal and polar displacements of strained Sr$_{1-x}$Ba$_x$MnO$_3$ enables tailoring of polarization when the film is subjected to boundary conditions imposed by epitaxial growth. Particularly, the oxygen content invokes considerable changes in the crystalline and electronic properties of the films, as it is shown elsewhere. In this respect, our work paves the way for understanding the impact of growth parameters on Sr$_{1-x}$Ba$_x$MnO$_{3-\delta}$ films and other compounds sharing equivalent chemical and crystalline structures.

This approach opens new possibilities for the design of a new concept of multiferroic films and heterostructures in which tailoring the polar distortions by chemical doping enables a broader control of the ferroic order and the magnetoelectric coupling of thin films, even grown with the same nominal stoichiometry of the target. Finally, rich and unexpected nanoscale phenomena may emerge from the design and study of chemistry-mediated heteropolar multilayers and motivate new approaches for the integration of ferroelectrics and multiferroics in future nanoelectronics.

IV. EXPERIMENTAL SECTION

Epitaxial Sr$_{1-x}$Ba$_x$MnO$_{3-\delta}$ thin films with compositions $x = 0, 0.4, 0.5$ and thicknesses in the range 7–18 nm were deposited on single crystalline (001)-oriented (LaAlO$_3$)$_{0.3}$(Sr$_2$TaAlO$_5$)$_{0.7}$ (LSAT) substrates from Crystal GmbH. The films were grown by pulsed laser deposition (PLD) using a KrF excimer laser, a fluence of 1 J/cm$^2$, and a pulse repetition rate of 10 Hz. The substrate temperature was set at 850 °C, with cooling/heating rates of 10 °C/min. In the case of SrMnO$_3$ the oxygen pressure during growth was set at 50 mTorr, while SMO films with $x = 0.4, 0.5$ were grown at 0.05 mTorr to reduce the Mn valence, increasing its ionic radius and thus favoring the stabilization of the pseudocubic perovskite phase. In situ post-growth annealing was performed to control the oxygen stoichiometry. SrMnO$_3$ epitaxial thin films were annealed at 800 °C for 30 min at O$_2$ pressures ranging from 300 to 500 Torr. Sr$_{0.3}$Ba$_{0.7}$MnO$_{3-\delta}$ films were annealed for 1 h at temperatures ranging from 250 to 750 °C and O$_2$ pressures between 300 and 590 Torr. Sr$_{0.3}$Ba$_{0.7}$MnO$_{3-\delta}$ films were annealed for 1 h at 650 °C in a range of pressures between 350 and 550 Torr.

The crystal structure and thickness of the films were studied by X-ray diffraction (XRD) and X-ray reflectivity (XRR), while atomistic-level analysis of the SMO films was performed by scanning transmission electron microscopy (STEM) (see Sec. IV in the supplementary material). The atomic displacements were measured from the ABF and HAADF images, and finally the film polarization was evaluated (see Fig. S6 in the supplementary material).

Electron energy loss spectroscopy (EELS) in STEM was performed to assess the oxygen content of the films. The fine structure of the background-subtracted O–K edge was fitted to a double Gaussian to quantify the Mn valence following the procedure described by Varela et al. In-plane deformation maps out of HAADF-STEM images were calculated using geometric phase analysis (GPA) to study locally the quality of substrate-induced strain in the films. Lamella specimens for STEM were prepared with an FEI Helios 650 Dual Beam system and the final thinning was performed by low-angle Ar$^+$ ion polishing in a Fischione 1010 ion mill. Energy dispersive x-ray analysis was carried out to estimate the chemical composition of the films with respect to the nominal composition of the targets.

SUPPLEMENTARY MATERIAL

Additional structural (XRD and STEM) and chemical x-ray microanalysis, a detailed description of the STEM image analysis and calculation of polarization images, including the LSAT substrate, and further details on the experimental conditions are provided in the supplementary material.

ACKNOWLEDGMENTS

We acknowledge the research Project No. PID2020-112914RB -100 funded by Grant No. MCIN/AEI/10.13039/501100011033. This work was funded from Regional Gobierno de Aragón through Project Nos. E13_23R and E28_23R, including FEDER funding and from the EU Horizon 2020 programme under the Marie Skłodowska-Curie Grant Agreement No. 861153 MANIC, and under the Grant Agreement No. 823717-ESTEEM3. The authors acknowledge the use of instrumentation as well as the technical advice provided by the National Facility ELECMI ICTS, node “Laboratorio de Microscopias Avanzadas (LMA)” at “Universidad de Zaragoza”.

We acknowledge Javier Blasco from INMA-CSIC (Zaragoza, Spain) for the synthesis of the PLD targets and Christophe Gatel from CEMES-CNRS (Toulouse, France) for the STEM image acquisition and drift correction scripts.

AUTHOR DECLARATIONS

Conflict of Interest

The authors have no conflicts to disclose.

Author Contributions

Panagiotis Koutsogiannis: Data curation (equal); Formal analysis (equal); Software (equal); Writing – original draft (equal). Pedro A. Algarabel: Investigation (supporting); Supervision (supporting); Writing – review & editing (equal). José A. Pardo: Conceptualization (equal); Funding acquisition (equal); Supervision (equal); Writing – review & editing (equal). César Magén: Conceptualization (lead); Funding acquisition (lead); Methodology (equal); Project administration (lead); Supervision (lead); Validation (lead); Writing – review & editing (equal).

DATA AVAILABILITY

The data that support the findings of this study are available from the corresponding author upon request.

REFERENCES

Microscopic origin of large negative magneto-electric coupling in $\text{KTaO}_3$.


V. T. Negus, “The $\text{Ba}_{0.5}\text{Sr}_{0.5}\text{MnO}_3$ system,” J. Solid State Chem. 6(1), 136–150 (1972).

O. Chmaissem, B. Dabrowski, S. Kolesnik, J. Mais, D. E. Brown, R. Kruk, P. Prior, B. Byles, and J. D. Jorgensen, “Relationship between structural parameters and the Néel temperature in $\text{Sr}_{1-x}\text{Ca}_{x}\text{MnO}_3$ ($0 \leq x \leq 1$) and $\text{Sr}_{1-x}\text{Ba}_{x}\text{MnO}_3$ ($0 \leq x \leq 0.2$),” Phys. Rev. B 64(13), 134412 (2001).


E. Langenberg, L. Maurel, G. Antorrena, P. A. Algarabel, C. Magén, and J. A. Pardo, “Relaxation mechanisms and strain-controlled oxygen vacancies in epitaxial $\text{Sr}_{1-x}\text{Ca}_x\text{MnO}_3$ films,” ACS Omega 6(20), 13144–13152 (2021).

